Hard X-ray FEL Lasing Through BBA and Radiation Spectrum Analysis

Heung-Sik Kang

On behalf of PAL-XFEL commissioning team

Pohang Accelerator Laboratory

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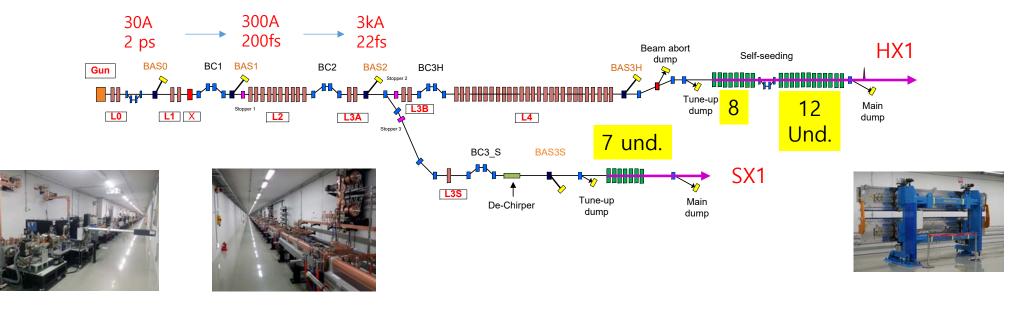
Contents

- Introduction to PAL-XFEL
- e-BBA
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- PAL-XFEL commissioning status
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PAL-XFEL 0.1 nm hard X-ray FEL using a 10 GeV normal conducting linac

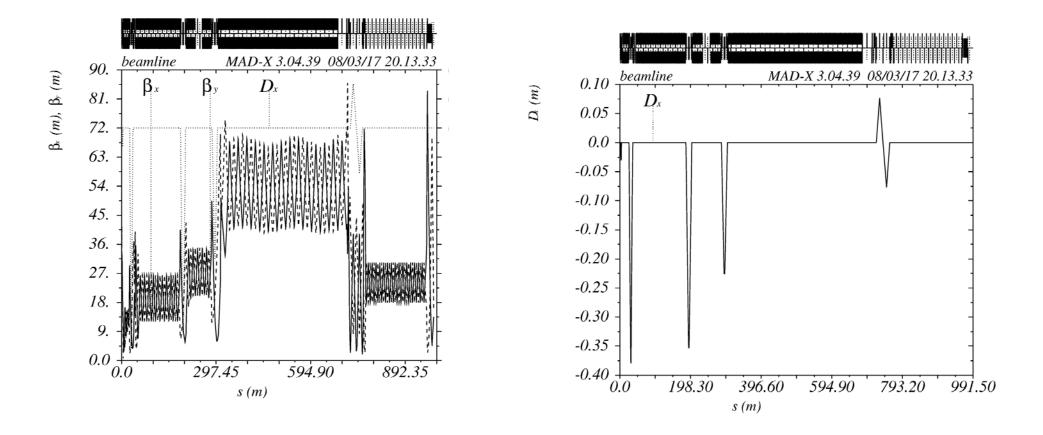
Apr. 2011:PAL-XFEL project startedJun. 2012:Ground-breakingDec. 2014:Building completedJan. 2016:Installation completedApr. 2016:Commissioning startedJun. 2017:User-service will start

PAL-XFEL Parameters



Main parameters		Undulator Line	HX1	SX1	
e ⁻ Energy	10 GeV	Wavelength [nm]	0.1 ~ 0.6	1 ~ 4.5	
e ⁻ Bunch charge Slice emittance	20-200 pC 0.5 mm mrad	Beam Energy [GeV]	4 ~ 10	3.15	
Repetition rate60 HzPulse duration10 fs - 100 fsPeak current3 kASX line switchingDC (Phase-1) Kicker (Phase-2)	Wavelength Tuning [nm]	0.6 ~ 0.1 (energy or gap)	4.5 ~ 3 (energy) 3 ~ 1 (gap)		
	DC (Phase-1)	Undulator Type	Planar, out-vac.	Planar	
		Undulator Period / Gap [mm]	26 / 8.3	35 / 8.3	

Lattice Function



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Klystron Gallery



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Linac Tunnel

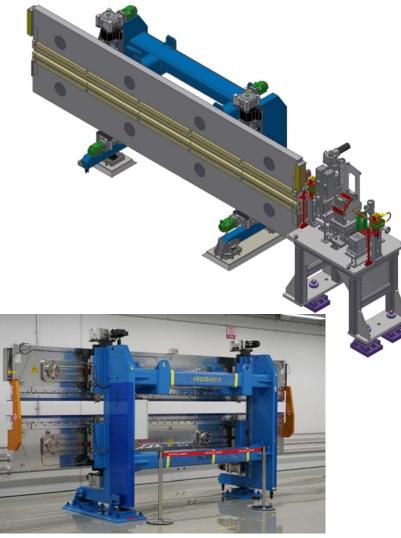


Undulator Hall



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Undulator Design



- We adopted the European XFEL undulator design, which features a 5-m-long, planar, permanent magnet and an out-vacuum variable-gap undulator
- and modified its magnet design according to the PAL-XFEL undulator parameters

Symbol	Unit	Nominal value
E	GeV	10.000
g	mm	8.30
λ _u	mm	26.0
L _{und}	m	5.0
λ _r	nm	0.1
B_{eff}	Tesla	0.8124
K		1.9727
Optical phase error	degree	less than 5.0

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Why we need e-BBA & K-tuning?

- **SASE FEL** is an interactive process between e-beam and photon beam through 100m long undulators.
- Dispersion-free orbits straight to within a few micrometres over the gain length is required to maximize the spatial overlap between the electron and photon beams.
 - e-beam based BBA (LCLS, fixed gap undulator)
 - **photon beam based BBA** (SACLA, variable-gap in-vacuum undulator)
- PAL-XFEL: variable gap out-vacuum undulator
 - e-BBA
 - Radiation spectrum analysis (K-tuning)
- Radiation spectrum analysis
 - -> accurate gap distances for *K* in each undulator segment
 - -> undulator field centre offsets,

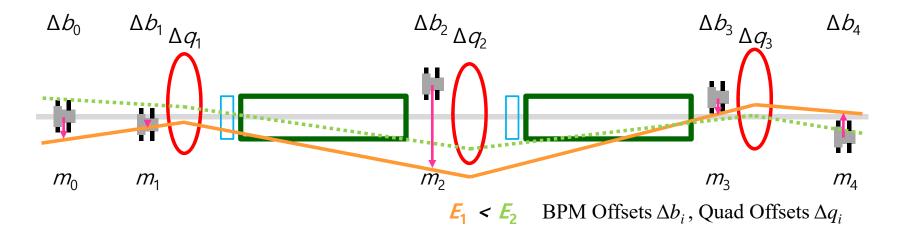
, which is particularly critical for variable-gap undulators.

Electron beam-based BBA (1)

• BBA measurement algorithm

- Henrik Loos, LCLS FAC, June 8, 2009)

- P. Emma et al. Beam-based alignment for the LCLS FEL undulator. NIM A 429, 407-413 (1999).

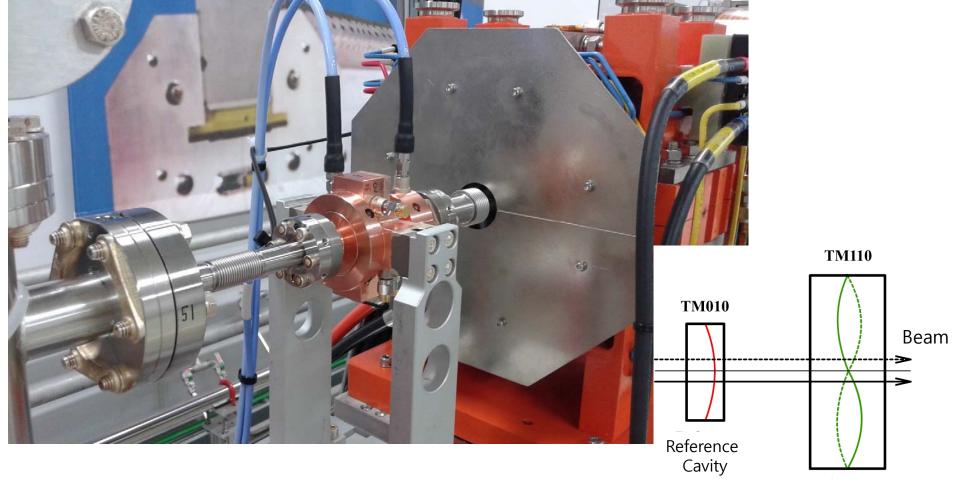


- Model beam position (m_j) at BPMs as function of

initial launch at 1st BPM (x_i), quad offsets (Δq_i), BPM offsets (Δb_i)

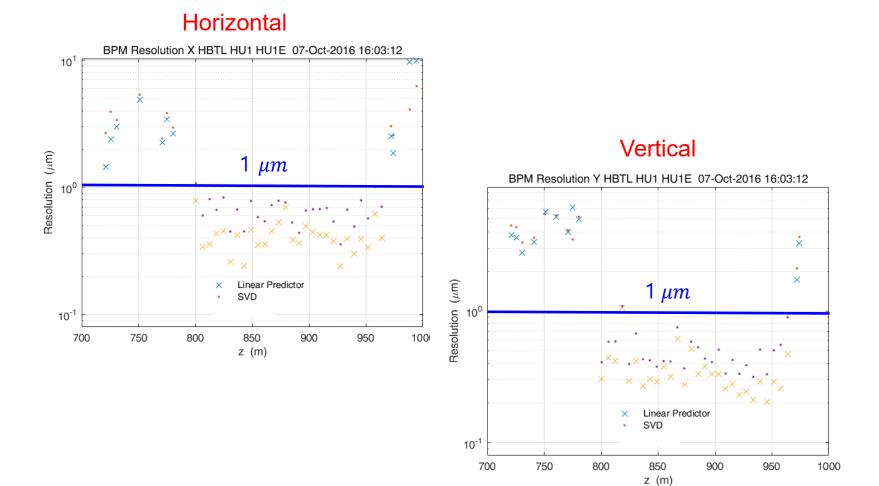
- m =
$$[R_x R_q R_b][x' \Delta q' \Delta b']'$$

PAL-XFEL Cavity BPM: X-band BPM



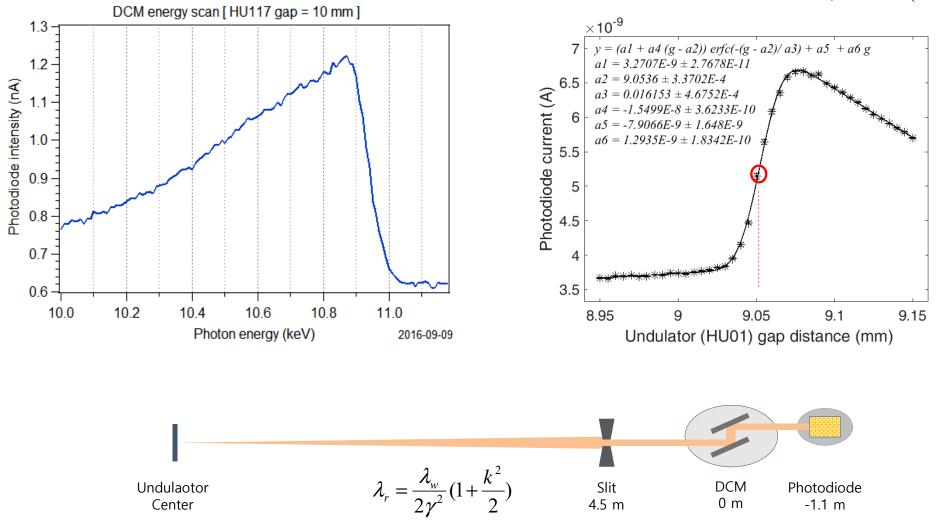
Dipole Cavity

HX Cavity BPM Resolution



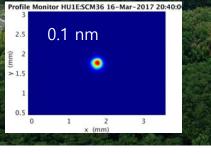
Radiation Spectrum Analysis: K-tuning

T. Tanaka *et al. Phys. Rev. ST* Accel. Beam **15**, 110701 (2012).



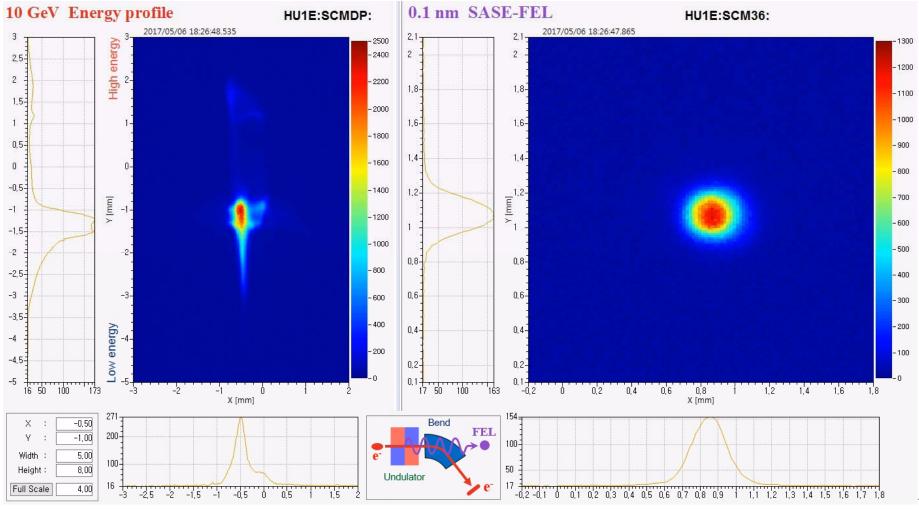
PAL-XFEL Commissioning

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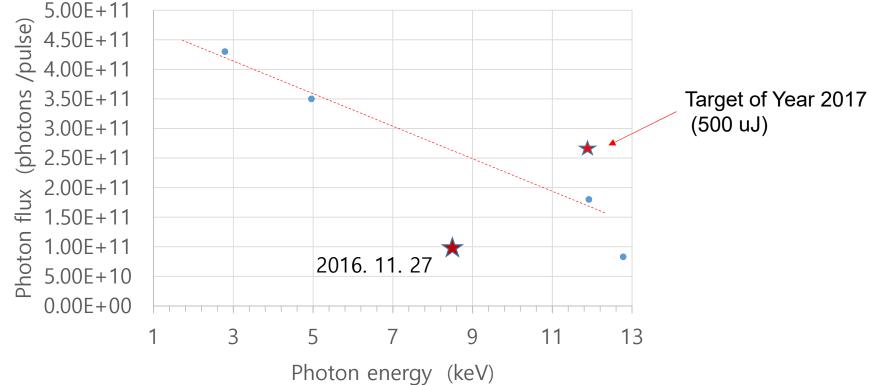
14 Jún. 2016 First SASE lasing at 0.5 nm
 28 Oct. 2016 Lasing at 0.15 nm
 27 Nov. 2016 Saturation of 0.15 nm
 16 Mar. 2017 Saturation of 0.1 nm¹⁵

Stability of 0.104 nm FEL



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Photon flux of Hard X-ray FEL (As of May 7, 2017)



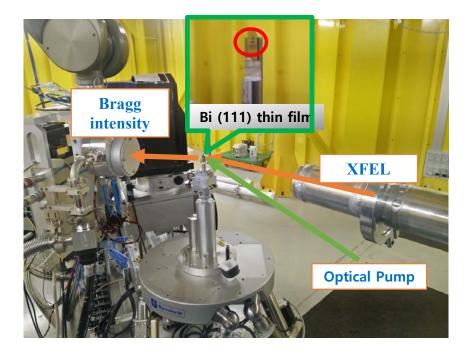
Date				Apr. 5	Apr. 07	
wavelength, nm	0.097	0.104	0.25	0.444	0.444	
photon energy, keV	12.78	11.92	4.96	2.79	2.79	
FEL pulse energy, mJ	0.17	0.34	0.28	0.177	0.192	
Number of photon per FEL pulse	8.3E+10	1.8E+11	3.5E+11	4.0E+11	4.3E+11	17

PAL-XFEL Beamline

- Photon energy: 2.8~12.9 keV
- Beam lines: 3 hard 2 soft X-ray beamlines (~80 m)



Demo Experiment: Optical Laser Pump – XFEL Probe X-ray Diffraction Bismuth (111) thin film



Bi(111) thin film (50 nm) on GaSb(111)/Si(111) X-ray: 6 keV X-ray size: ~ 60 x 60 um² Laser: 800 nm, 100 fs Detector: MPCCD 0.5M

Summary

- The **e-BBA** of the undulator lines enabled us to obtain **dispersionfree orbits** straight to within a few micrometres to maximize the spatial overlap between the electron and photon beams.
- The radiation spectrum analysis facilitated identification of the undulator field centre offsets and accurate gap distances for *K* in each undulator segment, which is particularly critical for variable-gap undulators.
- Using this procedure, we successfully achieved saturation of both 0.1 nm and 1.5 nm FEL beams in a very reliable and robust manner and delivered the FEL beams to each beamline for commissioning.

Acknowledgement

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